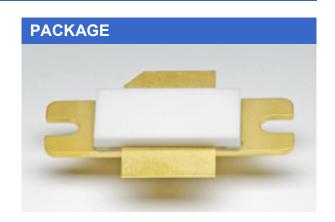


# HVV1012-550

550 Watts, 50V, 1025-1150MHz, 10μs Pulse, 1% Duty

## **FEATURES**

Silicon MOSFET Technology
Operation from 24V to 50V
High Power Gain
Extreme Ruggedness
Internal Input and Output Matching
Excellent Thermal Stability
All Gold Bonding Scheme
Pb-free and RoHS Compliant



## **TYPICAL PERFORMANCE**

At Pin	FREQUENCY	VDD	IDQ	Power	GAIN	η(%)	IRL	VSWR
(W)	(MHz)	(V)	(mA)	(W)	(dB)		(dB)	
12	1150	50	100	640	17.3	48	-12	20:1

Table 1: Typical RF Performance in broadband text fixture at 25°C temperature with RF pulse conditions of pulse width = 10µs and pulse duty cycle = 1%.

### **DESCRIPTION**

The high power HVV1012-550 device is an enhancement mode RF MOSFET power transistor designed for pulsed applications in the L-Band from 1025MHz to 1150MHz. The high voltage MOSFET technology produces over 550W of pulsed output power while offering high gain, high efficiency, and ease of matching with a 50 V supply. The vertical device structure assures high reliability and ruggedness as the device is specified to withstand a 20:1 VSWR at all phase angles under full rated output power.

### ORDERING INFORMATION

Device Part Number: HVV1012-550

Evaluation Kit Part Number: HVV1012-550-EK

REV. A

L-Band High Power Pulsed Transistor 1025-1150 MHz, 10µs Pulse, 1% Duty For Airborne DME Applications

## **ABSOLUTE MAXIMUM RATING (IEC 134)**

### THERMAL/RUGGEDNESS PERFORMANCE

Symbol	Parameter	Value	Unit
$V_{DSS}$	Drain-Source Voltage	95	٧
$V_{GSS}$	Gate-Source Voltage	-10, 10	٧
I <sub>DS(max)</sub>	Drain Current	40	Α
$P_D^{-1}$	Power Dissipation	5000	W
P <sub>in</sub>	Input Power	28	W
T <sub>S</sub>	Storage Temperature	-40 to	°C
		+150	
T <sub>J</sub>	Junction Temperature	200	°C

Symbol	Parameter	Max	Unit
$\theta_{\rm JC}^2$	Thermal Resistance	0.03	°C/W

Symbol	Parameter	Test Condition	Max	Units
LMT <sup>2</sup>	Load	F = 1150 MHz	20:1	VSWR
	Mismatch			
	Tolerance			

The HVV1012-550 device is capable of withstanding an output load mismatch corresponding to a 20:1 VSWR at rated output power and nominal operating voltage across the frequency band of operation.

## **ELECTRICAL CHARACTERISTICS**

Symbol	Parameter	Conditions	Min	Typic	Max	Unit
				al		
$V_{BR(DSS)}$	Drain-Source Breakdown	$V_{GS}=0V_{ID}=5mA$	95	102	-	V
$I_{DSS}$	Drain Leakage Current	$V_{GS}=0V, V_{DS}=50V$	-	100	400	μΑ
	Gate Leakage Current	$V_{GS}=5V, V_{DS}=0V$	-	2	10	μΑ
$I_{GSS}$ $G_P^2$	Power Gain	F=1025, 1150MHz, Pin=12W	16.5	17.3	-	dB
IRL <sup>2</sup>	Input Return Loss	F=1025, 1150MHz, Pin=12W	-	-12	-7	dB
$\eta_D^2$	Drain Efficiency	F=1025, 1150MHz, Pin=12W	44	48	-	%
Pout	Power out	F=1150MHz, Pin=12W	-	640	-	W
$V_{GS(Q)}^3$	Gate Quiescent Voltage	$V_{DD}$ =50V, $I_{DQ}$ =100mA	1.0	1.4	1.7	V
$V_{TH}$	Threshold Voltage	$V_{DD} = 5V, I_D = 300 \mu A$	0.7	1.2	1.7	V

Typical performance at 1025MHz with an input power of 12W.

$G_P^2$	Power Gain	F=1025MHz, Pin=12W	-	17	-	dB
IRL <sup>2</sup>	Input Return Loss	F=1025MHz, Pin=12W	-	-11	-	dB
$\eta_D^2$	Drain Efficiency	F=1025MHz, Pin=12W	-	54	-	%
Pout	Power out	F=1025MHz, Pin=12W	-	640	-	W

L-Band High Power Pulsed Transistor 1025-1150 MHz, 10µs Pulse, 1% Duty For Airborne DME Applications

## **PULSE CHARACTERISTICS**

Symbol	Parameter	Conditions	Min	Typical	Max	Units
t <sub>r</sub> <sup>4</sup>	Rise Time	F=1150MHz	-	<35	50	ns
$t_f^4$	Fall Time	F=1150MHz	-	<15	50	ns
PD <sup>4</sup>	Pulse Droop	F=1150MHz	-	0.1	0.3	dB

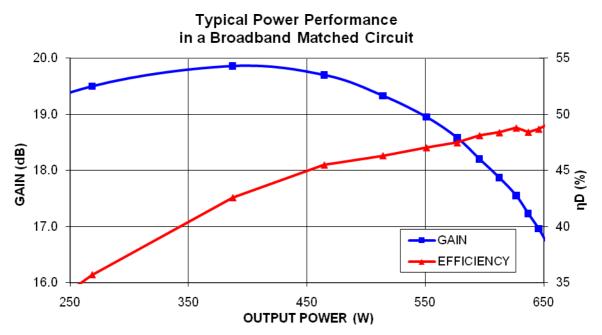
#### Notes:

1) Rated at  $T_{CASE} = 25^{\circ}C$ 

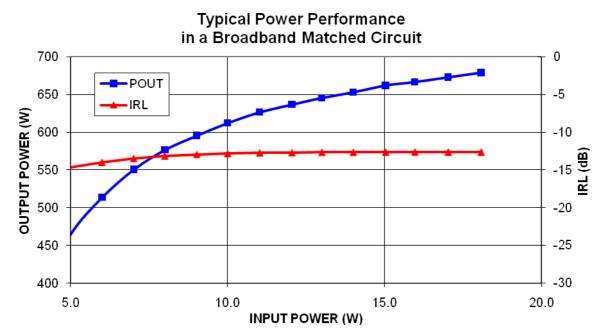
- 3) Amount of gate voltage required to attain nominal quiescent current.
- 4) Guaranteed by design.

<sup>2)</sup> All parameters measured under pulsed conditions at 12W input power measured at the 10% point of the pulse with pulse width =  $10\mu$ sec, duty cycle = 1% and  $V_{DD} = 50V$ ,  $I_{DQ} = 100$ mA in a broadband matched test fixture.

L-Band High Power Pulsed Transistor 1025-1150 MHz, 10µs Pulse, 1% Duty For Airborne DME Applications



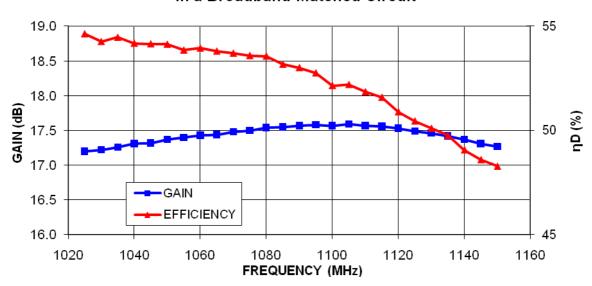
Typical device performance under Class AB mode of operation and RF pulse conditions of  $10\mu$ s pulse width and 1% duty cycle with  $V_{DD}$  = 50V and  $I_{DQ}$  = 100mA. The device was measured at 1150MHz.



Typical device performance under Class AB mode of operation and RF pulse conditions of  $10\mu$ s pulse width and 1% duty cycle with  $V_{DD}$  = 50V and  $I_{DQ}$  = 100mA. The device was measured at 1150MHz.

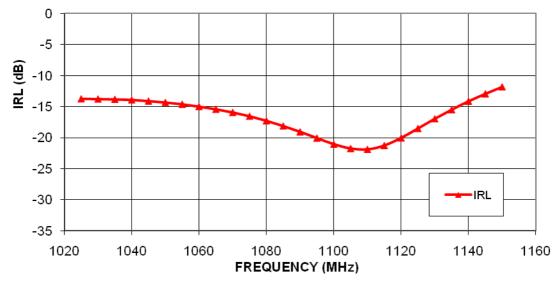
L-Band High Power Pulsed Transistor 1025-1150 MHz, 10µs Pulse, 1% Duty For Airborne DME Applications

# Typical Performance vs Frequency in a Broadband Matched Circuit



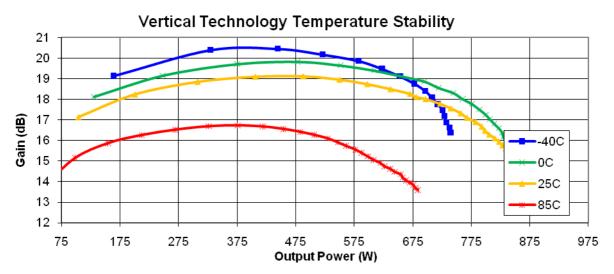
Typical device performance under Class AB mode of operation and RF pulse conditions of  $10\mu$ s pulse width and 1% duty cycle with  $V_{DD}$  = 50V and  $I_{DQ}$  = 100mA. The device was measured at an input power of 12W.

# Typical Performance vs Frequency in a Broadband Matched Circuit



Typical device performance under Class AB mode of operation and RF pulse conditions of 10 $\mu$ s pulse width and 1% duty cycle with  $V_{DD}$  = 50V and  $I_{DQ}$  = 100mA. The device was measured at an input power of 12W.

L-Band High Power Pulsed Transistor 1025-1150 MHz, 10µs Pulse, 1% Duty For Airborne DME Applications



Typical device performance under Class AB mode of operation at 1090MHz and RF pulse conditions of 10µs pulse width and 1% duty cycle with VDD = 50 V and IDQ = 100mA. The high voltage silicon vertical technology shows less than 1.5dB of power degradation over an extreme case teperature rise of 125°C.

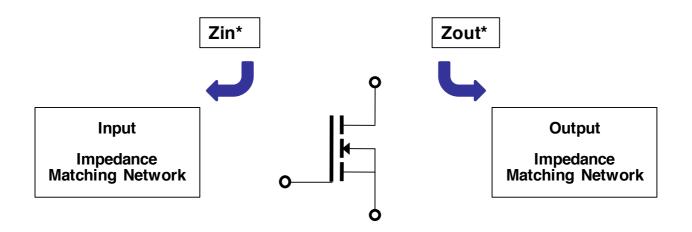
Measured at P1dB Compression Point					
TEMP	Gain (dB)	Power (W)	Power (dBm)		
-40C	19.5	622	57.9		
0C	18.9	695	58.4		
25C	18.1	681	58.3		
85C	15.7	561	57.5		

HVV1012-550 Performance over Temperature

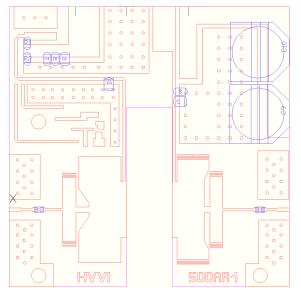
L-Band High Power Pulsed Transistor 1025-1150 MHz, 10µs Pulse, 1% Duty For Airborne DME Applications

# Test Circuit Impedances

Frequency	Zin* (ohms)	Zout* (ohms)
1025MHz	0.95-j1.4	1.2-j2.8
1060MHz	0.97-j1.2	1.1-j2.5
1150MHz	1.1-j0.66	1.0-j1.9



L-Band High Power Pulsed Transistor 1025-1150 MHz, 10µs Pulse, 1% Duty For Airborne DME Applications





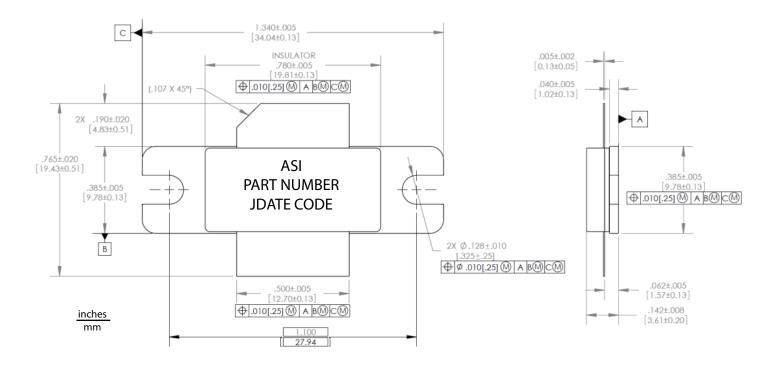
**Demonstration Board Outline** 

**Demonstration Circuit Board Picture** 

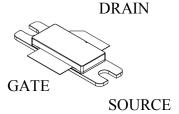
Part	Description	Part Number	Manufacturer
C1, C2:	39 pF AVX 805 Chip Capacitor	712-1388-1-ND	Digi Key
C3,C7:	39 pF ATC 1210 100B Chip Capacitor	478-2646-1-ND	Digi Key
C4:	1K pF 100V Chip Capacitor (X7R 1206)	399-1222-2-ND	Digi Key
C5, C8:	10K pF 100V Chip Capacitor (X7R 1206)	399-1236-2-ND	Digi Key
C6:	10 uF 6V Tantalum SMD	478-3134-1-ND	Digi Key
C9, C10:	220 uF 63V Elect FK SMD	PCE3484TR-ND	Digi Key
R1:	470 Ohms Chip Resistor (1206)	311-470ERCT-ND	Digi Key
R2:	100 K Ohms Chip Resistor (1206)	311-100KERCT-ND	Digi Key
RF Connectors	Type "N" RF connectors	5919CC-TB-7	Coaxicom
DC Drain Conn	Connector Jack Banana Nylon Red	J151-ND	DIGI-KEY
DC Ground Conn	Connector Jack Banana Nylon Black	J152-ND	DIGI-KEY
DC Gate Conn.	Connector Jack Banana Nylon Green	J153-ND	DIGI-KEY
PCB Board	PCB: 25 mils thick, 10.2 Dielectric, 1 oz Co	pper	DS Electronics
Device Clamp	HV800 Package Nylon Clamp Foot	FXT000116	Cool Innovation
Heat Sink	Cool Innovations Aluminum Heat Sink	3-252510RS3411	Cool Innovation
S.S. Screws (4)	4-40 X 1/4 Stainless Steel Socket Hex Head	P242393	Copper State Bolt
Alloy Screws (4)	4-40 X 1/2 Alloy Socket Cap screw Hex	SCAS-0440-08C	Small Parts Inc
Metal Washer (6)	#4 Washer Zinc PLTD Steel Lock	ZSLW-004-M	Small Parts Inc
Alloy Screws (2)	4-40 X 3/4 Alloy Socket Cap Screw Head	SCAS-0440-12M	Small Parts Inc

HVV1012-550 Demonstration Circuit Board Bill of Materials

### **PACKAGE DIMENSIONS**



Note: Drawing is not actual size.



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